

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)				<i>Complete if Known</i>	
				Application Number	10/730,387
				Filing Date	
				First Named Inventor	Mahibur Rahman et al.
				Group Art Unit	2611
Examiner Name	LF				
Sheet 1 of 1	Attorney Docket Number		SC12882ZC		

U. S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number - Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US -			
		US -			
		US -			
		US -			
		US -			
		US -			
		US -			
		US -			
		US -			

FOREIGN PATENT DOCUMENTS						
Examine Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>

NON PATENT LITERATURE DOCUMENTS		
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
LF	AA	LINDFORS et al., "A 3-V Continuous-Time Filter with On-Chip Tuning for IS-95," IEEE JOURNAL OF SOLID-STATE CIRCUITS, VOL. 34, NO. 8, AUGUST 1999, pp. 1150-1154.
LF	AB	YAMAZAKI et al., "WP23.1 A 450kHz CMOS Gm-C Bandpass Filter with +/-0.5% Center Frequency Accuracy for On-Chip PDC IF Receivers," 1999 IEEE INTERNATIONAL SOLID-STATE CIRCUITS CONFERENCE, ISSCC99/SESSION 23/PAPER WP 23.1, pp. 392-393, p. 482.
LF	AC	DURHAM et al., "Circuit Architectures for High Linearity Monolithic Continuous-Time Filtering," IEEE TRANSACTIONS ON CIRCUITS AND SYSTEMS—II: ANALOG AND DIGITAL SIGNAL PROCESSING, VOL. 39, NO. 9, SEPTEMBER 1992, pp. 651-657.

Examiner Signature	/Leon Flores/	Date Considered	01/25/2007
--------------------	---------------	-----------------	------------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation, if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Unique citation designation number. <sup>2</sup> See Kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English Language Translation is attached.

If you need assistance in completing the form, call 1-800-PTO-9199 (1-800-786-9199) and select option 2.